

# Gokin



## 23.0%

Module Efficiency up to

≤

First-year Degradation

≤

Annual Degradation



Module efficiency up to 23.0% based on N-Type wafer and TOPCon technology



Unsusceptible to LID, LeTID and less annual degradation due to special characteristics of N-Type



More power output in field operation due to better thermal behaviors, weak-light performance and bifaciality



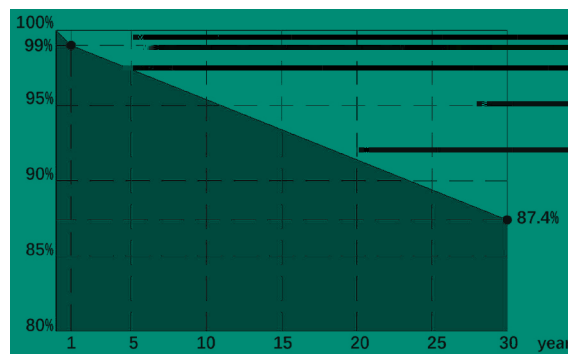
High module quality ensures long-term reliability



Product Warranty



Linear Power Warranty



At least 99% of nominal power during first year  
Thereafter max.0.4% degradation per year  
At least 87.4% of nominal power up to 30 years.



IEC 61215(2021) / IEC 61730(2023)  
ISO 9001: 2015: ISO Quality Management System  
Anti-PID / Ammonia / Salt-mist / Dust and sand

